
**Fine ceramics (advanced ceramics,
advanced technical ceramics) —
Test methods for optical properties
of ceramic phosphors for white
light-emitting diodes using a gonio-
spectrofluorometer**





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Contents

	Page
Foreword	v
Introduction	vi
1 Scope	1
2 Normative references	1
3 Terms and definitions	1
4 Spherical coordinate system	1
5 Measurement apparatus	2
5.1 Apparatus configuration	2
5.2 Light source unit	4
5.3 Sample unit	4
5.3.1 Cell	4
5.3.2 Diffuse reflectance standard	4
5.3.3 Sample stage	4
5.4 Detection unit	5
5.4.1 Directing optical system	5
5.4.2 Spectrometer and detector	5
5.4.3 Amplifier	5
5.5 Rotational positioning unit	5
5.5.1 Mechanism for setting angle of incidence	5
5.5.2 Mechanism for setting zenith angle of observation	5
5.5.3 Mechanism for setting azimuth angle of observation	5
5.6 Enclosure	5
5.7 Signal and data processing unit	6
6 Calibration, inspection and maintenance of measurement apparatus	6
6.1 General	6
6.2 Wavelength calibration of light source unit	6
6.3 Cells	6
6.4 Diffuse reflectance standard	6
6.5 Wavelength calibration of detection unit	6
6.6 Spectral responsivity calibration	6
6.7 Rotational positioning unit	6
7 Samples	6
7.1 Storage and pre-processing	6
7.2 Filling cells with samples	7
8 Measurement procedures	7
8.1 Measurement environment	7
8.2 In-plane spatial distribution measurement	7
8.2.1 Goniometric measurement of diffuse reflectance standard	7
8.2.2 Gonio-spectrofluorometric measurement of phosphor sample	7
8.3 Measurement of spatial light distribution with varying azimuth angle of observation	8
8.4 Evaluation of surface uniformity with varying azimuth rotational angle of sample	8
9 Calculation	8
9.1 Relative spectral distribution	8
9.1.1 Spectral responsivity and accumulation time corrections	8
9.1.2 Mean spectrum for varying azimuth rotational angle of sample	8
9.2 Conversion to photon number-based spectral distribution	9
9.3 Calculation of scattered light and fluorescence photon numbers	10
9.3.1 Scattered light photon number for diffuse reflectance standard	10
9.3.2 Scattered and fluorescence photon numbers for phosphor sample	11
9.4 Average of scattered light or fluorescence photon number for variable azimuth angle of observation	12